INTEGRATED CIRCUITS



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HEF4751V LSI

DESCRIPTION

The HEF4751V is a universal divider (U.D.) intended for use in high performance phase lock loop frequency synthesizer systems. It consists of a chain of counters operating in a programmable feedback mode. Programmable feedback signals are generated for up to three external (fast) \div 10/11 prescaler.

The system comprising one HEF4751V U.D. together with prescalers is a fully programmable divider with a maximum configuration of: 5 decimal stages, a programmable mode M stage ($1 \le M \le 16$, non-decimal fraction channel selection), and a mode H stage (H = 1 or 2, stage for half

channel offset). Programming is performed in BCD code in a bit-parallel, digit-serial format. To accommodate fixed or variable frequency offset, two numbers are applied in parallel, one being subtracted from the other to produce the internal programme. The decade selection address is generated by an internal programme counter which may run continuously or on demand. Two or more universal dividers can be cascaded, each extra U.D. (in slave mode) adds two decades to the system. The combination retains the full programmability and features of a single U.D. The U.D. provides a fast output signal FF at output OFF, which can have a phase jitter of \pm 1 system input period, to allow fast frequency locking. The slow output signal FS at output OFS, which is jitter-free, is used for fine phase control at a lower speed.



HEF4751VP(N): 28-lead DIL; plastic (SOT117)
HEF4751VD(F): 28-lead DIL; ceramic (cerdip) (SOT135V)
HEF4751VT(D): 28-lead SO; plastic (SOT136A)
(): Package Designator North America

SUPPLY VOLTAGE

RATING	RECOMMENDED OPERATING
–0,5 to + 18	4,5 to 12,5 V

FAMILY DATA, I_{DD} LIMITS category LSI

See Family Specifications

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Product specification

Universal divider

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Universal divider



Allocation of data input

FETCH		INPUTS							
PERIOD	\overline{A}_3	\overline{A}_2	$\overline{\mathbf{A}}_{1}$	\overline{A}_{0}	\overline{B}_3	\overline{B}_2	$\overline{\mathbf{B}}_1$	\overline{B}_0	SI
0	n _{0A}				n _{0B}				b _{in}
1		n	1A		n _{1B}			Х	
2	n _{2A}			n _{2B}			Х		
3	n _{3A}			n _{3B}			Х		
4	n _{4A}			n _{4B}				Х	
5		n _{5A}			n _{5B}				Х
6	М			C cor	0 _b ntrol	1 cha cor	∕₂ nnel ntrol	Х	

Allocation of data input $\overline{B}3$ to $\overline{B}0$ during fetch period 6

B ₃	\overline{B}_2	C0 _b DIVISION RATIO
L	L	1
L	Н	2
н	L	5
н	Н	10/11

B ₁	\overline{B}_0	1/2 CHANNEL CONFIGURATION
L	L	H = 1
L	Н	$H = 2; n_h = 0$
Н	Н	H = 2; n _h = 1
Н	L	test state

Notes

- 1. H = HIGH state (the more positive voltage)
- 2. L = LOW state (the less positive voltage)
- 3. X = state is immaterial

PROGRAMME DATA INPUT (see also Figs 3 and 4)

The programming process is timed and controlled by input PC and PE. When the programme enable (PE) input is HIGH; the positive edges of the programme clock (PC) signal step through the internal programme counter in a sequence of 8 states. Seven states define fetch periods, each indicated by a LOW signal at one of the corresponding data address outputs (OD_0 to OD_6). These data address signals may be used to address the external programme source. The data fetched from the programme source is applied to inputs \overline{A}_0 to \overline{A}_3 and \overline{B}_0 to \overline{B}_3 . When PC is LOW in a fetch period an internal load pulse is generated, the data is valid during this time and has to be stable. When PE is LOW, the programming cyclus is interrupted on the first positive edge of PC. On the next negative edge at input PC fetch period 6 is entered. Data may enter asynchronously in fetch period 6.

Ten blocks in the U.D. need programme input signals (see Fig.2). Four of these (C0_b, C3, C4 and RSH) are concerned with the configuration of the U.D. and are programmed in fetch period 6. The remaining blocks (RS0 to RS4 and C1) are programmed with number P, consisting of six internal digits n_0 to n_5 .

$$\mathsf{P} = (\mathsf{n}_5 \cdot 10^4 + \mathsf{n}_4 \cdot 10^3 + \mathsf{n}_3 \cdot 10^2 + \mathsf{n}_2 \cdot 10 + \mathsf{n}_1) \cdot \mathsf{M} + \mathsf{n}_0$$

These digits are formed by a substractor from two external numbers A and B and a borrow-in (b_{in}) .

$$\begin{split} \mathsf{P} &= \mathsf{A} - \mathsf{B} - \mathsf{b}_{\text{in}} \text{ or if this result is negative;} \\ \mathsf{P} &= \mathsf{A} - \mathsf{B} - \mathsf{b}_{\text{in}} + \mathsf{M} \cdot 10^5. \end{split}$$

The numbers A and B, each consisting of six four bit digits n_{0A} to n_{5A} and n_{0B} to n_{5B} , are applied in fetch period 0 to 5 to the inputs \overline{A}_0 to \overline{A}_3 (data A) and \overline{B}_0 to \overline{B}_3 (data B) in binary coded negative logic.

- $\begin{aligned} A &= (n_{5A} \cdot 10^4 + n_{4A} \cdot 10^3 + n_{3A} \cdot 10^2 + n_{2A} \cdot 10 + n_{1A}) \cdot M \\ &+ n_{0A}. \end{aligned}$
- $$\begin{split} B &= (n_{5B} \cdot 10^4 + n_{4B} \cdot 10^3 + n_{3B} \cdot 10^2 + n_{2B} \cdot 10 + n_{1B}) \cdot M \\ &+ n_{0B}. \end{split}$$

Borrow-in (b_{in}) is applied via input SI in fetch period 0 (SI = HIGH: borrow, SI = LOW: no borrow).

Counter C1 is automatically programmed with the most significant non-zero digit (n_{ms}) from the internal digits n_5 to n_2 of number P. The counter chain C – 2 to C1 (see Fig.3) is fully programmable by the use of pulse rate feedback.

Rate feedback is generated by the rate selectors RS4 to RS0 and RSH, which are programmed with digits n_4 to n_0 and n_h respectively. In fetch period 6 the fractional counter C3, half channel counter C4 and C0_b are programmed and configured via data B inputs. Counter C3

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is programmed in fetch period 6 via data A inputs in negative logic (except all HIGH is understood as: M = 16). The counter C0 is a side steppable 10/11 counter composed of an internal part C0_b and an external part C0_a. C0_b is configured via \overline{B}_3 and \overline{B}_2 to a division ratio of 1 or 2 or 5 or 10/11; C0_a must have the complementary ratio 10/11 or 5/6 or 2/3 or 1 respectively. In the latter case C0_b comprises the whole C0 counter with internal feedback, C0_a is then not required.

The half channel counter C4 is enabled with \overline{B}_0 = HIGH and disabled with \overline{B}_0 = LOW. With C4 enabled, a half channel offset can be programmed with input \overline{B}_1 = HIGH, and no offset with \overline{B}_1 = LOW.

FEEDBACK TO PRESCALERS (see also Figs 5 and 6)

The counters C1, C0, C-1 and C-2 are side-steppable counters, i.e. its division ratio may be increased by one, by applying a pulse to a control terminal for the duration of one division cycle. Counter C2 has 10 states, which are accessible as timing signals for the rate selectors RS1 to RS4. A rate selector, programmed with n (n_1 to n_4 in the U.D.) generates n of 10 basic timing periods an active signal. Since $n \le 9$, 1 of 10 periods is always non-active. In this period RS1 transfers the output of rate selector RS0, which is timed by counter C3 and programmed with n₀. Similarly, RS0 transfers RSH output during one period of C3. Rate selector RSH is timed by C4 and programmed with n_h. In one of the two states of C4, if enabled, or always, if C4 is disabled, RSH transfers the LOW active signal at input RI to RS0. If RI is not used it must be connected to HIGH. The feedback output signals of RS1, RS2 and RS3 are externally available as active LOW signals at outputs \overline{OFB}_1 , \overline{OFB}_2 and \overline{OFB}_3 .

Output \overline{OFB}_1 is intended for the prescaler at the highest frequency (if present), \overline{OFB}_2 for the next (if present) and \overline{OFB}_3 for the lowest frequency prescaler (if present). A prescaler needs a feedback signal, which is timed on one of its own division cycles in a basic timing period. The timing signal at \overline{OSY} is LOW during the last U.D. input period of a basic timing period and is suitable for timing of the feedback for the last external prescaler. The synchronization signal for a preceding prescaler is the OR-function of the sync. input and sync. output of the following prescaler (all sync. signals active LOW).

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CASCADING OF U.D.s (see also Fig. 8)

A U.D. is programmed into the 'slave' mode by the programme input data: $n_{2A} = 11$, $n_{2B} = 10$, $n_{3A} = n_{4A} = n_{3B} = n_{4B} = n_{5B} = 0$. A U.D. operating in the slave mode performs the function of two extra programmable stages C2' and C3' to a 'master' (not slave) mode operating U.D. More slave U.D.s may be used, every slave adding two lower significant digits to the system.

Output \overline{OFB}_3 is converted to the borrow output of the programme data subtractor, which is valid after fetch period 5. Input SI is the borrow input (both in master and in slave mode), which has to be valid in fetch period 0. Input SI has to be connected to output \overline{OFB}_3 of a following slave, if not present, to LOW. For proper transfer of the borrow from a lower to a higher significant U.D. subtractor, the U.D.s have to be programmed sequentially in order of significance or synchronously if the programme is repeated at least the number of U.D.s in the system.

Rate input $\overline{\text{RI}}$ and output OFS must be connected to rate output $\overline{\text{OFB}}_1$ and the input IN of the next slave U.D. The combination thus formed retains the full programmability and features of one U.D.

OUTPUT (see also Fig.7)

The normal output of the U.D. is the slow output OFS, which consists of evenly spaced LOW pulses. This output is intended for accurate phase comparison. If a better frequency acquisition time is required, the fast output OFF can be used. The output frequency on OFF is a factor M \cdot H higher than the frequency on OFS. However, phase jitter of maximum \pm 1 system input period occurs at OFF, since the division ratio of the counters preceding OFF are varied by slow feedback pulse trains from rate selectors following OFF.



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Product specification

Universal divider

Philips Semiconductors





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DC CHARACTERISTICS

V _{SS} :	= 0	V
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							-	Г _{ать} (°С)			
	V _{DD} V	V _{OH} V	V _{OL}	SYMBOL	_4	40	+ 2	25	+	85	
		_	_		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Output (sink)	4,75		0,4		1,6		1,4		1,1		mA
current LOW	5		0,4	I _{OL}	1,7		1,5		1,2		mA
	10		0,5		2,9		2,7		2,2		mA
Output (source)	5	4,6			1,0		0,85		0,55		mA
current HIGH	5	2,5		1	3,0		2,5		1,7		mA
	10	9,5		-'OH	3,0		2,5		1,7		mA

AC CHARACTERISTICS

 V_{SS} = 0 V; T_{amb} = 25 °C; input transition times \leq 20 ns

PARAMETER	V _{DD} V	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Propagation delay	5	4		135	270	ns	
$IN\to\overline{OSY}$	10	PHL		45	90	ns	$C_L = 10 \text{ pr}$
HIGH to LOW							
Output transition							
times							
HIGH to LOW	5	4		30	60	ns	
	10	ITHL		12	25	ns	$C_L = 50 \text{ pr}$
LOW to HIGH	5	4		45	90	ns	
	10	ITLH		20	40	ns	$C_L = 50 \text{ pr}$
Maximum input	5	f _{max}	4	8		MHz	$\delta = 50\%$
frequency; IN	10		12	24		MHz	C0 _b ratio > 1
Maximum input	5	f _{max}	2	4		MHz	$\delta = 50\%$
frequency; IN	10		6	12		MHz	C0 _b ratio = 1
Maximum input	5	f _{max}	0,15	0,3		MHz	
frequency; PC	10		0,5	1,0		MHz	

	V _{DD} V	TYPICAL FORMULA FOR P (μ W)	
Dynamic power			where
dissipation per	5	1 200 f _i + Σ (f _o C _L) × V _{DD} ²	f _i = input freq. (MHz)
package (P)	10	5 400 f _i + Σ (f _o C _L) \times V _{DD} ²	f _o = output freq. (MHz)
			C_L = load capacitance (pF)
			Σ (f _o C _L) = sum of outputs
			V _{DD} = supply voltage (V)